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Application/Control No.	Applicant(s)/Patent under Reexamination
10/706,238	KAN, MAKIKO
Examiner	Art Unit
Sun J. Lin	2825

SEARCHED			
Class	Subclass	Date	Examiner
716	1	12/20/2005	JSL
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
EAST [USPAT;US- PGPUB;EPO;JPO;DERWENT;IBM_T DB]	12/20/2005	JSL
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